


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551763	<b>Applicant(s)/Patent Under Reexamination</b>  HAMIDI ET AL.
	<b>Examiner</b>  Nguyen, Khiem D	<b>Art Unit</b>  2823

SEARCHED			
Class	Subclass	Date	Examiner
257	177, 687, 689, 788, E23.181, E23.183	10/23/2007	/KN/
438	117, 121, 127	10/23/2007	/KN/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	10/25/2007	/KN/
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	7/23/2008	/KN/
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	3/5/2009	/KN/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/KHIEM D NGUYEN/ Examiner.Art Unit 2823	
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